Nanopatterned Graphene on a Polymer Substrate by a Direct Peel-off Technique

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ABSTRACT: A graphene (Gr) on a polyimide (PI) polymer film (Gr−PI film), obtained by a direct peel-off technique, is proposed and investigated. Thanks to its high transparency, electrical conductivity, mechanical strength, and chemical durability, the Gr−PI film is an ideal substrate for flexible electronic and optoelectronic devices, including transistors, light-emitting diodes, and plasmonic antennas. It is obtained using a straightforward method. After spin coating and curing a PI film on Gr previously grown on Cu, one can separate the Gr−PI film from the Cu foil thanks to the difference in the adhesive energy between the Gr−Cu and Gr−PI interfaces. The resulting Gr−PI film shows an average electrical sheet resistance ranging from 520 to 860 Ω/sq and a very high optical transmission (>90%), which have allowed the demonstration of a transparent heater. The surface morphology of the Gr−PI film follows that of the Cu foil, with the latter maintaining its surface properties and allowing in this way its reuse in subsequent chemical vapor deposition growth. The method can also be applied to patterned Gr, as is demonstrated for nanosize ribbons with a width of a few tens of nanometers.

KEYWORDS: peel-off, graphene transfer, graphene pattern, polymer substrate, flexible substrate

INTRODUCTION

In recent years, graphene (Gr) has attracted enormous interest because of its unique physical and chemical properties.1−3 It is worth noting that chemical vapor deposition (CVD) has paved the way to industrial production of Gr.4−6 To date, the majority of Gr research and development has focused on rigid substrates such as SiO2 on Si, SiC, or glass.7−10 However, there is a strong need in using flexible substrates, such as poly(ethylene terephthalate) and thin glass, for making devices that can be bent or even folded and being able to use inexpensive roll-to-roll fabrication techniques. This is the case, for example, for organic solar cells (OSCs), organic light-emitting diodes, and plasmonic nanoantennas.11 Gr needs then to be directly grown or transferred on the flexible substrates. Transfer is still preferred for the high-quality layers obtained on catalytic metals, e.g., Cu, Pt, and Ni, using CVD. Poly(methyl methacrylate) (PMMA) is used as a supporting layer in wet-solution transfer but an adhesive layer in hot-pressing/lamination.12−15 Besides an additional intermediate layer, an etching process is usually needed to remove the underlying Cu foil, which would thus be wasted. A poly(dimethylsiloxane) (PDMS) polymer was used as a sacrificial solid block to facilitate the handling process during a wet-etching process.16−18 In another experiment, it was also used to exfoliate Gr from another Gr layer thanks to the weak adhesive force between neighboring Gr layers.19 However, PDMS has never been used for peeling off Gr grown on Cu because the bonding force that one has to overcome in this case is much higher than that between Gr layers. Recently, in the case of the hot-pressing/lamination method, water has been proposed to avoid etching because it can penetrate through a capillary effect between Gr and the adhesive layer to partially separate them. The price of Cu foil is quite high, a practical limit for the industrial use of CVD-grown Gr if it is not reused.

In this paper, a new Gr on a polyimide (PI) film (Gr−PI film) is proposed and investigated as a substrate for electronic and optoelectronic applications. PI films have already been employed as durable and flexible substrates or intermediate layers in microelectronics, OSCs, and aerospace applications thanks to their high transparency, chemical and mechanical resistance, and easy processing.20 Several scalable fabrication techniques exist for depositing PI over large areas such as Doctor blade, Meyer rod, or spray-coating methods.21−24 The Gr−PI film is obtained by using an etching-free transfer method consisting of depositing a layer of PI on Gr previously grown on a Cu substrate and peeling the Gr off thanks to the fact that the interface binding energy between PI and Gr is larger than that between the Cu foil and Gr. The resulting Gr−PI film has high optical transparency and electrical conductivity. In addition, the integrity of the Cu foil is preserved after the
Synthesis of a Gr Film. Gr films were grown on 35-μm-thick Cu foils (BHZN-Z-HA, JX Nippon Mining & Metals) cut into a 1 × 1 in.² dimensions. The Cu foil was first cleaned with acetone, isopropl alcohol, and acetic acid for 20, 20, and 3 min, respectively. Then, the Cu foil was placed into the PE-CVD chamber (Black Magic 4 in., AIXTRON). When the vacuum reached 0.1 mbar, N₂ and Ar flows were introduced into the system at 250:250 sccm ratios, respectively. Meanwhile, a pretreatment with H₂ (1000 sccm) is implemented for the Cu foil from room temperature to the reaction temperature, which is very beneficial for removing any residual oxide and increasing the grain size of Cu. After a slow ramping up to 1000 °C, the reaction gases were fed into the system (CH₄, 15 sccm; H₂, 60 sccm) while keeping the pressure at a constant value of 25 mbar. For full coverage of a 1 × 1 in.² substrate, the optimum reaction time was 7.5 min. Finally, the sample was cooled with a low H₂ pressure in order to remove any unwanted amorphous C from the surface.

Fabrication of Gr—PI. Initially, a PI polymer solution (VTEC-080-051) was spin-coated onto Gr on Cu foil (Gr/Cu foil) and subsequently annealed at 100 °C for 10 min, followed by another step at 180 °C for 10 min. The annealing process can dry and solidify PI into a thin film. PI was then peeled-off from the Cu foil to obtain a solid, smooth, and free-standing flexible Gr—PI film with Gr firmly attached to PI. The thickness of the PI film can be controlled by adjusting the spin-coater speed. In this work, by using a coating speed of 1000 rpm, the thickness of the PI film was about 5 μm.

Fabrication of Gr Nanoribbons. Gr nanoribbons were fabricated on a SiO₂/Si substrate by electron-beam lithography and reactive ion etching. An electron-beam negative resist (Allresist AR-N 7500.08) was spin-coated at 4000 rpm for a thickness of around 100 nm on a Gr/SiO₂/Si substrate and successively baked at 90 °C for 1 min. The AR-N resist was exposed to a 50 kV electron beam at 25 pA current (Crestec CABL 9000C). Gr was then patterned with Ar/O₂ reactive ion etching. The AR-N resist was successively removed with NEP solvent soaking.

Characterization. A PerkinElmer Lambda 950 spectrometer was used for optical transmission measurements, while a four-point probe and a standard Van der Pauw method was used for electrical sheet resistance measurements. The surface morphology of the films was characterized by optical and atomic force microscopy (AFM; D3100). The quality of Gr was assessed using Raman spectroscopy (Renishaw InVia Raman microscope).

Transparent Heater. A source with a potentiometer was used to apply the voltage. The temperature was recorded as a function of time using a Fluke 566 IR thermometer. The temperature distribution images of the heater were taken by an IR camera.

RESULTS AND DISCUSSION

Figure 1 shows the schematic steps of the proposed etching-free Gr transfer process, where the Cu foil can be reused to deposit a new monolayer Gr on its top by following the same CVD process.

Figure 2a shows a Raman mapping image of as-grown CVD of Gr on Cu foil. The average peak intensity ratio between the 2D and G bands is about 2.8 without any appearance of a defect-related D band over the whole scanning area (10 × 10 μm²), indicating a high-quality monolayer structure. Figure 2b shows an optical microscopic image of PI on Gr/Cu foil. The same figure (right-hand side) shows that the PI thin film could be easily peeled off from Cu foil. This simple peel-off process allows one to transfer Gr without any cumbersome Cu etching step. As was mentioned previously, the underlying Cu foil can be flattened and reused. Figure 2c shows two Raman spectra (point scans) for it before and after the peel-off process. Typical bands for Gr (2D and G peaks) are clearly present before the peel-off process, two defect-related peaks (D and D’ bands) are almost negligible, and also the 2D/G ratio gives a value of about 3.1, indicating a high-quality monolayer structure. In contrast, after the peel-off process, there is no sign of any Raman peak, essentially resembling the typical spectrum of bare Cu foil.

These trends were also confirmed over the full scanned area of about 50 × 50 μm². The damage (ablation) threshold of the ultrathin PI film under laser irradiation is quite low (see S1 in the Supporting Information, SI); therefore, direct detection of Gr on the PI film by a Raman technique was only performed in a low-laser-intensity regime and for a short exposure time. Figure 3 shows the Raman spectra for PI and Gr—PI, respectively. It can be clearly seen that the 2D peak is present in the Gr—PI sample. However, because of a large background noise from the PI film, the typical G band could not be detected because it overlaps with significant noise (see also the spectrum for only the PI film, which confirms the large noise from the substrate). To investigate further the uniformity of the Gr layer on PI, we extended the Raman mapping scan over an area of about 10 × 10 μm² to examine the 2D peak intensity distribution. As is shown in the inset of Figure 3, a relatively high intensity of the 2D peak is present over the whole detected area, a strong indication of a continuous Gr layer. Similar mapping scans were performed over several randomly selected areas and gave consistent results. Therefore, one can conclude that the Gr grown on Cu foil is entirely transferred to the PI film.

The Gr—PI film shows an important feature: that is, its surface morphology reproduced the initial Cu foil morphology (Figure 4a,b). This is another confirmation that the Gr—PI layer was peeled off completely without any damage. CVD-grown Gr on a thicker Cu plate was also tested, and the Raman data given in S2 in the SI show the typical Gr bands despite a large Cu plate thickness (2 mm). Subsequently, the peel-off process was applied to this case, and the result is quite similar to the case of Cu foil.

The same peel-off process was also successfully applied to Gr transferred on a glass substrate via the PMMA-assisted method (see S3 in the SI). Several groups have reported that the adhesive energies in Gr—glass and Gr—Cu are about 0.45 and 0.72 J m⁻², respectively. In addition, the adhesion forces for both cases, the higher force for the latter substrate is believed to be associated with a much higher
electronic density at the interface. Regardless, our experiments suggest that the adhesion force of Gr−PI is higher than that between the “Gr−Cu foil” and “Gr−glass” interfaces. The transfer can be attributed to a uniform wetting process of a liquid−solid (PI on Gr) interface, which is then solidified during the PI thermal curing, resulting in a stronger adhesion force than that of the solid−solid (Gr on Cu or Gr on glass) interface generated during CVD or transfer.

As for the case of Gr on Cu, for Gr on glass the peel-off process replicated the surface morphology of the glass substrate, i.e., its smoothness, in the resulting Gr−PI film. A comparison of the AFM images of the Gr−PI films peeled off from Cu foil and glass substrate indicates that the Gr−PI film peeled off from Cu foil has a much rougher surface morphology (see S3 in the SI). The surface roughness produces light scattering, with this feature being unwanted in several applications, for example, displays where high visibility (clarity) is required, but welcomed in others, for example, thin film solar cells, where it can be used to enhance light trapping and harvesting.28−30 Figure 5 shows the direct optical transmittance and average haze of the samples: the PI film peeled off from glass substrate, Gr−PI film peeled off from glass substrate, and Gr−PI film peeled off from Cu foil.
much lower direct transmission (about 65–70%) because the rest of the light is scattered off the collecting angle of the detector. This is confirmed by the significantly larger haze (26%).

The electrical sheet resistance of the peeled-off Gr–PI film was evaluated by a standard Van der Pauw method and gave values ranging from 520 to 860 Ω/sq. To demonstrate the effective electrical conduction as well as uniformity of the transferred Gr layer on the PI film, the Gr–PI film was used to fabricate a transparent thin-film heater (TTFH) based on Joule’s effect. TTFHs are very versatile for smart windows and displays, acting as antifogging and deicing surfaces. Because of the outstanding thermal conductivity of Gr, Gr-based TTFHs can give an extra advantage. In this work, the active area of the Gr–PI-based TTFH was 1 × 1 in.² (inset of Figure 6a). The temperature was recorded for different electrical powers over about 60 s. The temperature increased quite rapidly toward a saturation level (Figure 6a). The temperature uniformity of the Gr–PI-based TTFH sample was confirmed by taking an IR image when the maximum temperature was reached (Figure 6b), which further confirms the uniformity and continuity of the transferred Gr. In addition, the mechanical robustness and surface conduction of the Gr–PI film were found to be high by continuous bending and twisting in any direction without observation of any degradation in the conduction properties (video M1 in the SI).

To demonstrate that Cu foil could be reused after peeling off from the Gr–PI film, the same foil was flattened by a plain cold press (pressure of 100 psi) and cleaned with acetone, isopropyl alcohol, and acetic acid for 20, 20, and 3 min, respectively. Subsequently, Cu foil was placed in the plasma-enhanced CVD chamber for Gr growth using the same conditions as those of the first growth. Figure 7a shows the Raman spectrum for the new Gr layer on the reused Cu foil, providing evidence of its high quality.

The new Gr layer was transferred to a standard SiO₂/Si substrate by a conventional PMMA-assisted method. In this case, the underlying Cu foil was etched away by floating the PMMA/Gr/Cu sandwich structure in a concentrated FeCl₃ solution (1 M) at room temperature for about 3.5 h, and then the Gr–PMMA film was rinsed in deionized water and directly transferred onto a SiO₂/Si substrate. Finally, PMMA was completely dissolved with acetone. Figure 7a shows the Raman spectrum for the transferred Gr on a SiO₂/Si substrate, exhibiting a monolayer Gr with excellent quality (I₂D/Iᴳ = 2.3 and I Dön/Iᴳ = 0.11). Because of a clear optical contrast, the transferred Gr on SiO₂/Si could be visualized effectively through an optical microscope (Figure 7b), showing an almost crack/wrinkle-free and clean Gr surface. The Raman mapping scan over the 10 × 10 μm² area also provided more evidence about the quality of the transferred Gr. Parts c and d of Figure 7 indicate an average peak intensity ratio between the 2D and G bands of about 2, while the one between the D and G bands is almost negligible (only 0.04). If one plots the distribution of I₂D/Iᴳ over the scanning area into a histogram, one can clearly observe that the centered peak value is about 3 (see S4 in the SI). All of these measurements confirm the high quality of the Gr layer and that the proposed peel-off process allows one to reuse Cu foil as the substrate for subsequent growth.

In order to assess the potential of the proposed Gr–PI film and its fabrication method for light and flexible electronics and optoelectronics, micro- and nanopatterns of Gr were also demonstrated because they are often required to realize devices. One should note that common patterning techniques face challenges during processing of a flexible polymer substrate.
because of its deformation and instability.\textsuperscript{32–34} In this paper, we first patterned a Gr nanoribbon structure onto a SiO\textsubscript{2}/Si substrate by electron-beam lithography. By using the peel-off process previously described, the Gr nanoribbons were directly transferred onto the PI film. Figure 8a shows the schematic of Gr nanoribbons on a SiO\textsubscript{2}/Si substrate. A typical Gr Raman signal was detected before the process, while it was absent within the same area on the SiO\textsubscript{2}/Si substrate after the peel-off process (as shown in Figure 8b). Parts c and d of Figure 8 are the SEM images before and after the peel-off process for the SiO\textsubscript{2}/Si and PI substrates, respectively. This clearly demonstrates the versatility of the proposed method to achieve patterned Gr on polymer, even at nanoscale dimensions.

\section*{CONCLUSIONS}
A new Gr on the PI film has been proposed as a flexible polymer substrate with high transparency, electrical conductivity, and mechanical and chemical stability for electronic and optoelectronic applications. A transparent heater based on the PI film was demonstrated. The technique to produce it consisted of a simple peel-off process after deposition and solidification of PI on top of Gr on a Cu substrate. Cumbersome and not always clean etching required in common transfer processes could be avoided. In addition, Cu foil maintained its surface morphology and chemistry after the process, making its reuse possible and lowering in this way its costs. We also showed that patterned Gr down to the nanoscale could be achieved on a PI film by using the same process. This can be important for nanoelectronic and nanooptic devices including miniature, fast transistors and optical antennas.

\section*{ASSOCIATED CONTENT}
\section*{Supporting Information}
Ablation effect during the direct detection of Gr on the PI film by a Raman technique (S1), Raman spectrum for Gr grown on a thicker Cu plate by CVD (S2), peel-off process from Gr transferred onto a glass substrate (S3), a histogram distribution of the Gr peak intensity ratio of 2D/G over the scanning area for the transferred Gr (S4), and a demonstration of the mechanical robustness and surface conduction of the Gr–PI film (video M1). This material is available free of charge via the Internet at http://pubs.acs.org.

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The authors declare no competing financial interest.

\section*{ACKNOWLEDGMENTS}
We acknowledge financial support from the Spanish Ministry of Economy and Competitiveness and “Fondo Europeo de Desarrollo Regional” through Grant TEC2013-46168-R. Partial support was also received by Corning Inc. T.L.C. acknowledges financial support through a Ramon y Cajal fellowship.

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